

Sub E1
G1

32. (Twice amended) A polishing pad assembly for polishing a semiconductor wafer, said assembly comprising:

a belt forming a closed loop; and

at least one chemical mechanical planarization polishing pad mounted on the belt;
wherein said belt is formed of metal.

Sub E2
G2

34. (Twice amended) A polishing pad assembly for polishing a semiconductor wafer, said assembly comprising:

a first roller;

at least one additional roller;

a belt forming a closed loop, which belt is mounted on said first roller and said at least one additional roller;

at least one chemical mechanical planarization polishing pad mounted to said belt;

and

a drive system coupled to at least said first roller to rotate said first roller and to cause said belt and said chemical mechanical planarization polishing pad to move in a path;
wherein said belt is formed of metal.

Sub E3
G3

36. (Amended) A polishing pad assembly for polishing a semiconductor wafer, said assembly comprising:

a belt forming a closed loop; and

at least one chemical mechanical planarization polishing pad mounted on the belt;
wherein said belt comprises a polyurethane material.

Sub F3

37. (Amended) A polishing pad assembly for polishing a semiconductor wafer, said assembly comprising:

a first roller;

at least one additional roller;

a belt forming a closed loop, which belt is mounted on said first roller and said at least one additional roller;

at least one chemical mechanical planarization polishing pad mounted to said belt;

and

a drive system coupled to at least said first roller to rotate said first roller and to cause said belt and said chemical mechanical planarization polishing pad to move in a path; wherein said belt comprises a polyurethane material.

38. (Amended) A polishing pad assembly for polishing a semiconductor wafer, said assembly comprising:

a belt forming a closed loop; and

at least one chemical mechanical planarization polishing pad mounted on the belt;

wherein said belt comprises a high-strength polymer.

Sub G4 F4

40. (Amended) A polishing pad assembly for polishing a semiconductor wafer, said assembly comprising:

a first roller;

at least one additional roller;